


<b>Search Notes</b>  	<b>Application/Control No.</b>  10578267	<b>Applicant(s)/Patent Under Reexamination</b>  OTSUKA ET AL.
	<b>Examiner</b>  Nguyen, Khai M	<b>Art Unit</b>  2819

SEARCHED			
Class	Subclass	Date	Examiner
341	115-116	07/06/2007	KN

SEARCH NOTES		
Search Notes	Date	Examiner
341/111-112, 115-116, 1555; 324/202, 207.12, 207.2, 207.25; 702/87, 151; 318/605, 608, 611; 701/41; 250/213.16, 231.13; and with limited text search.	7/10/2007	KN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner